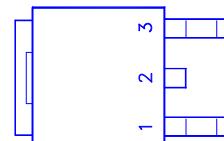
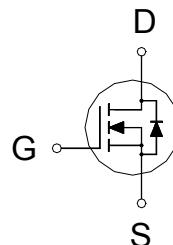


**NIKO-SEM**
**N-Channel Enhancement Mode  
Field Effect Transistor**
**P0603BD**  
**TO-252**  
**Halogen-Free & Lead-Free**
**PRODUCT SUMMARY**

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D$
30	5.8mΩ	70A

**ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ\text{C}$  Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D$	70	A
		44	
Pulsed Drain Current <sup>1</sup>	$I_{DM}$	180	
Avalanche Current	$I_{AS}$	28	
Avalanche Energy	$E_{AS}$	120	mJ
Power Dissipation	$P_D$	51	W
		20	
Operating Junction & Storage Temperature Range	$T_j, T_{stg}$	-55 to 150	
Lead Temperature ( $\frac{1}{16}$ " from case for 10 sec.)	$T_L$	275	°C

**THERMAL RESISTANCE RATINGS**

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$	2.45	62.5	°C / W
Junction-to-Ambient	$R_{\theta JA}$			

<sup>1</sup>Pulse width limited by maximum junction temperature.
**ELECTRICAL CHARACTERISTICS ( $T_C = 25^\circ\text{C}$ , Unless Otherwise Noted)**

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	30			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1	1.6	3	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 20V$			$\pm 250$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 24V, V_{GS} = 0V$			1	$\mu\text{A}$
		$V_{DS} = 20V, V_{GS} = 0V, T_J = 125^\circ\text{C}$			10	

**NIKO-SEM**
**N-Channel Enhancement Mode  
Field Effect Transistor**
**P0603BD**

TO-252

Halogen-Free &amp; Lead-Free

On-State Drain Current <sup>1</sup>	I <sub>D(ON)</sub>	V <sub>DS</sub> = 10V, V <sub>GS</sub> = 10V	70			A
Drain-Source On-State Resistance <sup>1</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 30A		6.2	9	mΩ
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 30A		4.6	5.8	
Forward Transconductance <sup>1</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 20A		90		S
<b>DYNAMIC</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 15V, f = 1MHz		2110		pF
Output Capacitance	C <sub>oss</sub>			469		
Reverse Transfer Capacitance	C <sub>rss</sub>			336		
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V, f = 1MHz		1.4		Ω
Total Gate Charge <sup>2</sup>	Q <sub>g</sub>	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 10V, I <sub>D</sub> = 25A		44		nC
Gate-Source Charge <sup>2</sup>	Q <sub>gs</sub>			8		
Gate-Drain Charge <sup>2</sup>	Q <sub>gd</sub>			9		
Turn-On Delay Time <sup>2</sup>	t <sub>d(on)</sub>	V <sub>DD</sub> = 15V, I <sub>D</sub> ≈ 25A, V <sub>GS</sub> = 10V, R <sub>GEN</sub> = 25Ω		23		nS
Rise Time <sup>2</sup>	t <sub>r</sub>			36		
Turn-Off Delay Time <sup>2</sup>	t <sub>d(off)</sub>			88		
Fall Time <sup>2</sup>	t <sub>f</sub>			35		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T<sub>c</sub> = 25 °C)</b>						
Continuous Current	I <sub>S</sub>	I <sub>F</sub> = I <sub>S</sub> , V <sub>GS</sub> = 0V V <sub>GS</sub> = 0V, dI <sub>S</sub> /dt = 100A/μs , I <sub>S</sub> = 30 A			39	A
Forward Voltage <sup>1</sup>	V <sub>SD</sub>				1.3	V
Reverse Recovery Time	t <sub>rr</sub>			55		nS
Reverse Recovery Charge	Q <sub>rr</sub>			25		nC

<sup>1</sup>Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.<sup>2</sup>Independent of operating temperature.

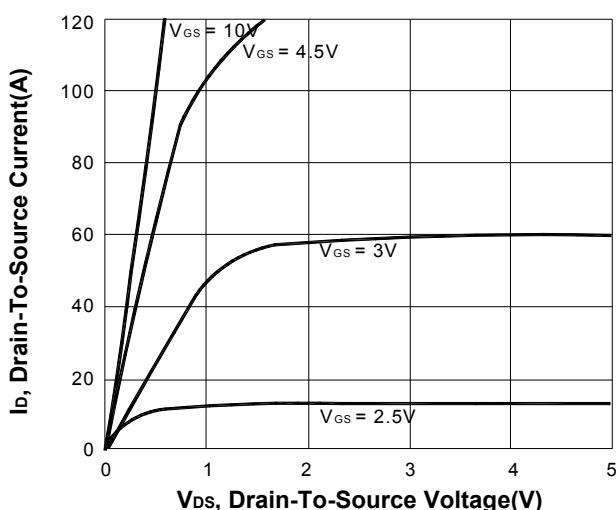
REMARK: THE PRODUCT MARKED WITH "P0603BD", DATE CODE or LOT #

**NIKO-SEM**

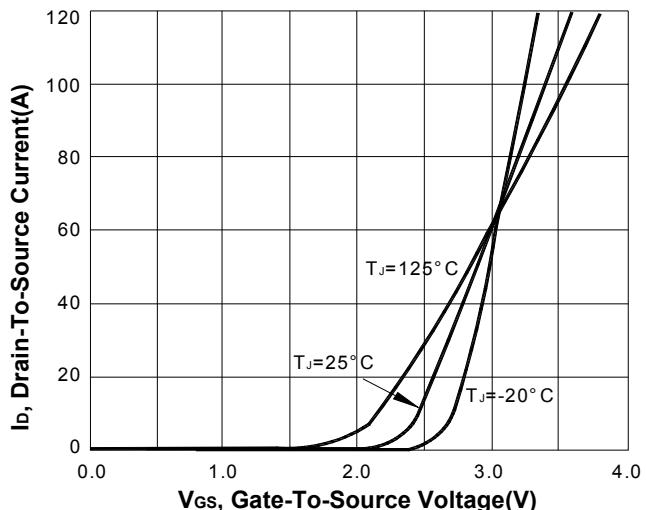
**N-Channel Enhancement Mode  
Field Effect Transistor**

**P0603BD**  
**TO-252**  
**Halogen-Free & Lead-Free**

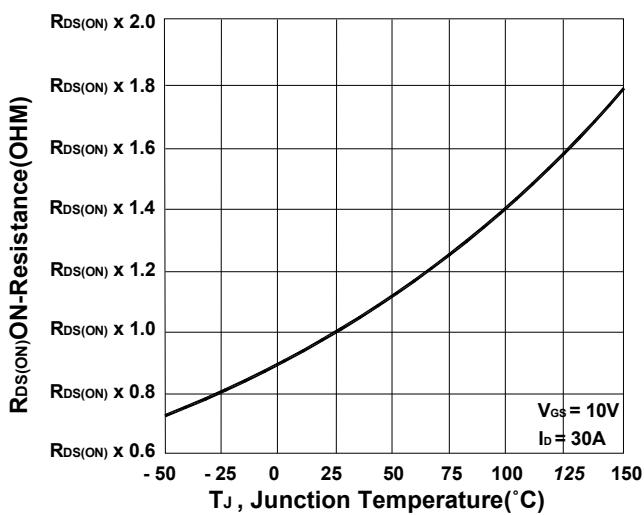
**Output Characteristics**



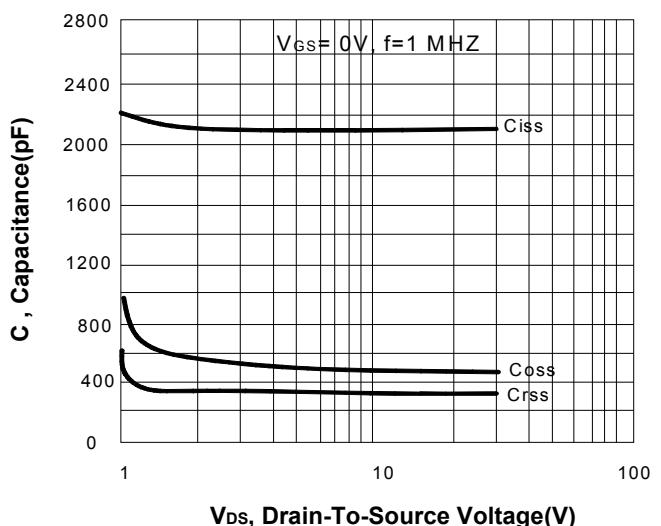
**Transfer Characteristics**



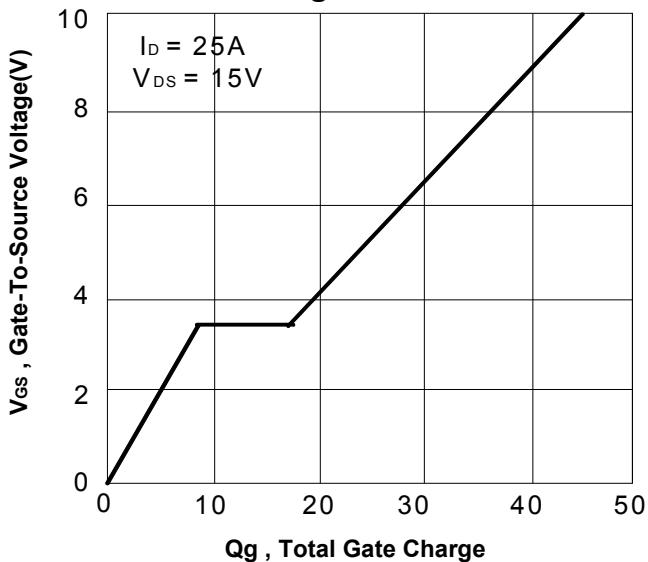
**On-Resistance VS Temperature**



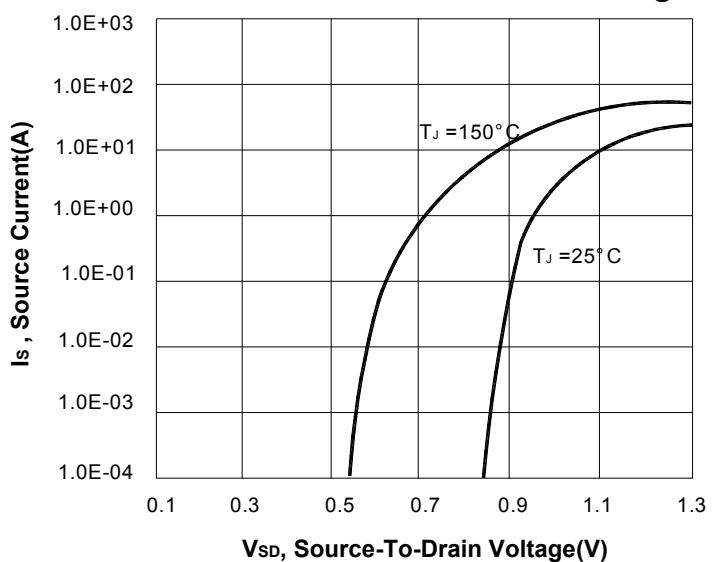
**Capacitance Characteristic**



**Gate charge Characteristics**



**Source-Drain Diode Forward Voltage**

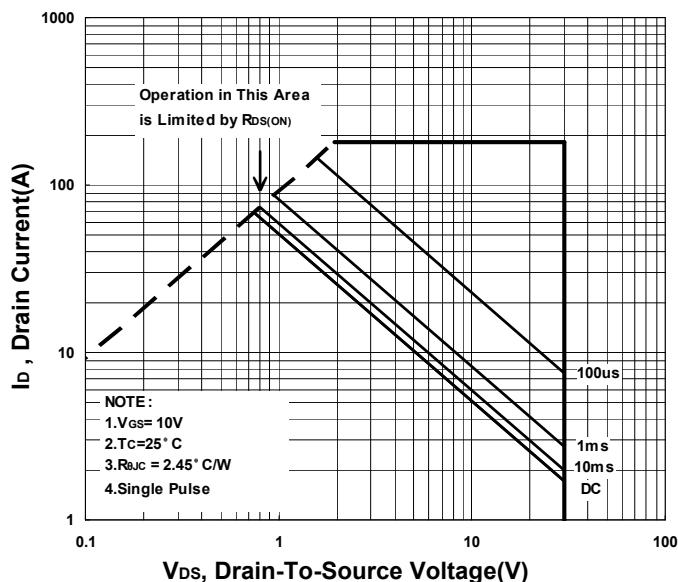


**NIKO-SEM**

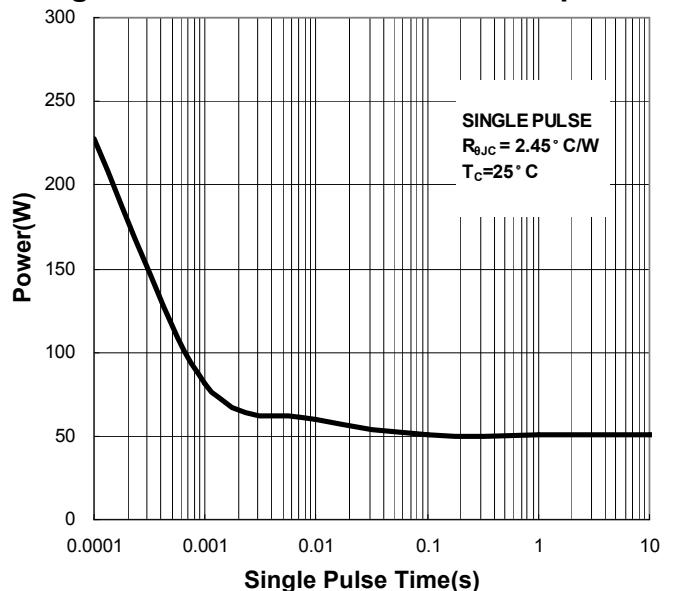
**N-Channel Enhancement Mode  
Field Effect Transistor**

**P0603BD**  
**TO-252**  
**Halogen-Free & Lead-Free**

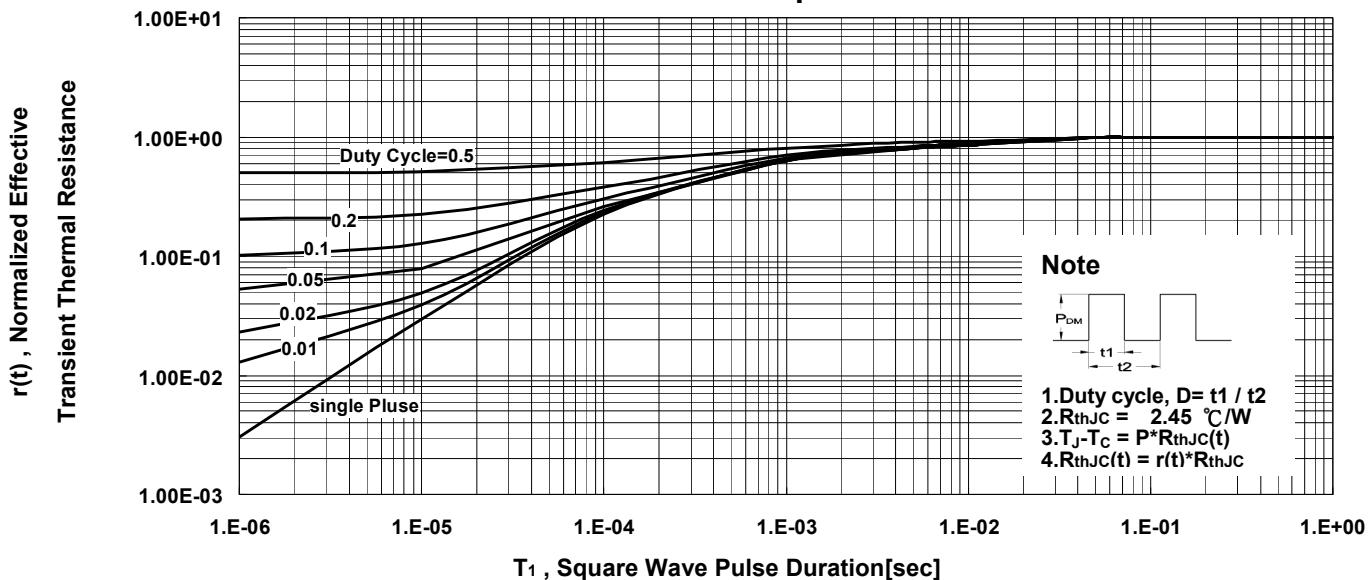
**Safe Operating Area**



**Single Pulse Maximum Power Dissipation**

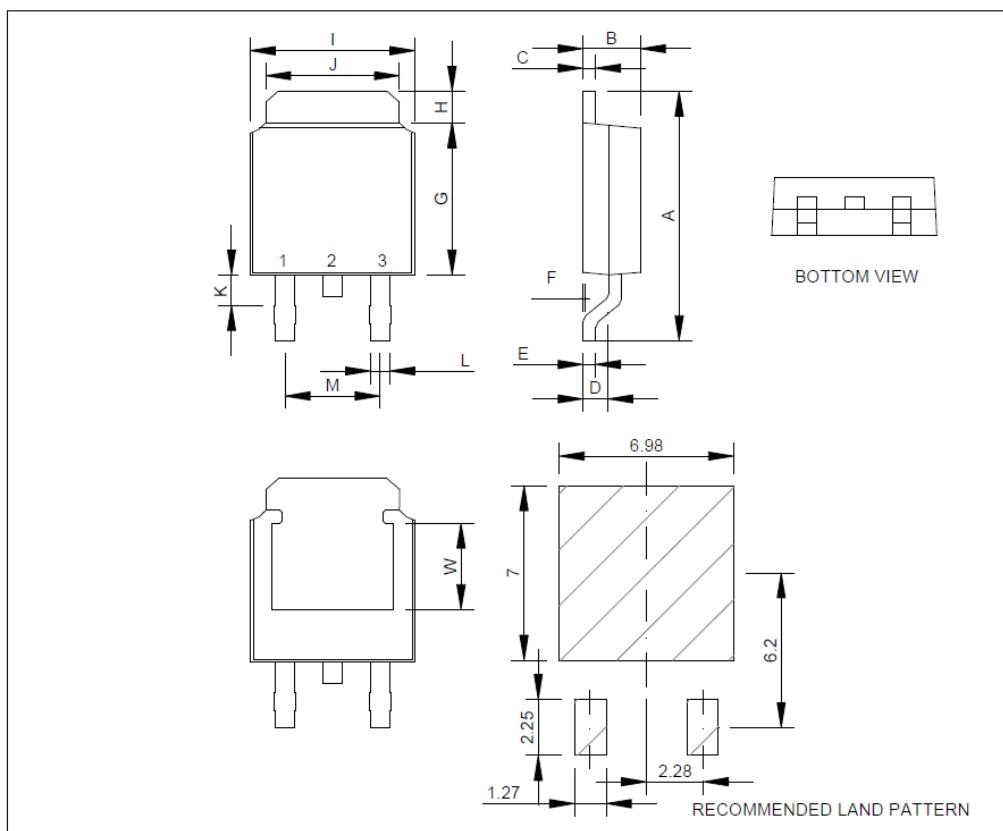


**Transient Thermal Response Curve**



**NIKO-SEM****N-Channel Enhancement Mode  
Field Effect Transistor****P0603BD  
TO-252  
Halogen-Free & Lead-Free****Package Dimension****TO-252 (DPAK) MECHANICAL DATA**

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	8.9	9.5	10.4	H	0.8	1.27	2.03
B	2.19	2.3	2.435	I	6.35	6.6	6.8
C	0.35	0.5	0.65	J	4.8	5.34	5.5
D	0.89		1.5	K	0.5		1.5
E	0.35		0.65	L	0.4	0.76	0.89
F	0.0		0.23	M	3.96		5.18
G	5.4		6.2	W	3.38	3.58	3.78



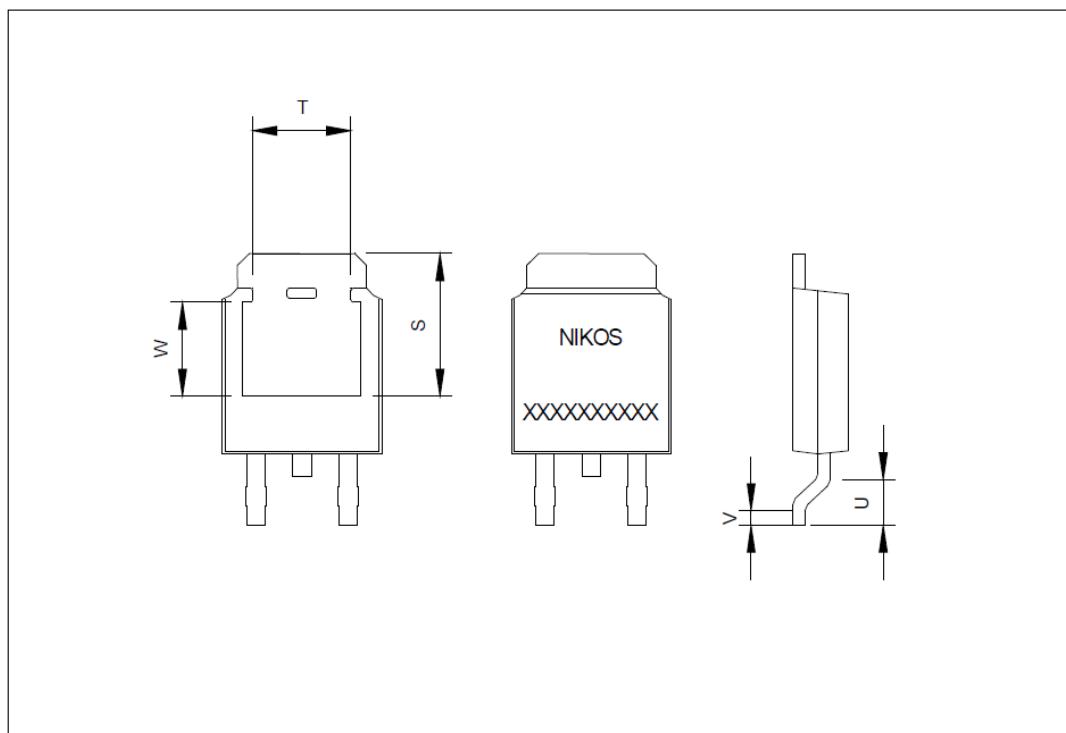
**NIKO-SEM**

**N-Channel Enhancement Mode  
Field Effect Transistor**

**P0603BD**  
**TO-252**  
**Halogen-Free & Lead-Free**

**TO-252 (DPAK) MECHANICAL DATA 散熱片**

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
S	4.57	5.249	5.6	U	1.4		3
T	3.81	4.064	5	V	0.95		1.1



# X-ON Electronics

Largest Supplier of Electrical and Electronic Components

*Click to view similar products for MOSFET category:*

*Click to view products by NIKO manufacturer:*

Other Similar products are found below :

[614233C](#) [648584F](#) [MCH3443-TL-E](#) [MCH6422-TL-E](#) [FDPF9N50NZ](#) [FW216A-TL-2W](#) [FW231A-TL-E](#) [APT5010JVR](#) [NTNS3A92PZT5G](#)  
[IRF100S201](#) [JANTX2N5237](#) [2SK2464-TL-E](#) [2SK3818-DL-E](#) [FCA20N60\\_F109](#) [FDZ595PZ](#) [STD6600NT4G](#) [FSS804-TL-E](#) [2SJ277-DL-E](#)  
[2SK1691-DL-E](#) [2SK2545\(Q,T\)](#) [D2294UK](#) [405094E](#) [423220D](#) [MCH6646-TL-E](#) [TPCC8103,L1Q\(CM](#) [367-8430-0972-503](#) [VN1206L](#)  
[424134F](#) [026935X](#) [051075F](#) [SBVS138LT1G](#) [614234A](#) [715780A](#) [NTNS3166NZT5G](#) [751625C](#) [873612G](#) [IRF7380TRHR](#)  
[IPS70R2K0CEAKMA1](#) [RJK60S3DPP-E0#T2](#) [RJK60S5DPK-M0#T0](#) [APT5010JVFR](#) [APT12031JFLL](#) [APT12040JVR](#) [DMN3404LQ-7](#)  
[NTE6400](#) [JANTX2N6796U](#) [JANTX2N6784U](#) [JANTXV2N5416U4](#) [SQM110N05-06L-GE3](#) [SIHF35N60E-GE3](#)